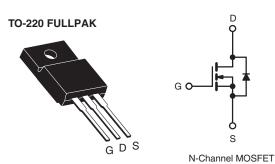
Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	60				
R _{DS(on)} (Ω)	$V_{GS} = 5 V$	0.028			
Q _g (Max.) (nC)	66				
Q _{gs} (nC)	12				
Q _{gd} (nC)	43				
Configuration	Single				



FEATURES

f = 60 Hz)

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{BMS} (t = 60 s; RoHS COMPLIANT
- Sink to Lead Creepage Distance = 4.8 mm
- · Logic-Level Gate Drive
- $R_{DS(on)}$ Specified at V_{GS} = 4 V and 5 V
- · Fast Switching
- · Ease of Paralleling
- · Lead (Pb)-free

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRLIZ44GPbF
	SiHLIZ44G-E3

ABSOLUTE MAXIMUM RATINGS $T_C = 25 \text{ °C}$, unless otherwise noted							
PARAMETER			SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V _{DS}	60	V			
Gate-Source Voltage			V _{GS}	± 10	V		
Continuous Drain Current	V_{GS} at 5 V $T_C = 28$ $T_C = 10$	T _C = 25 °C	- I _D	30			
		T _C = 100 °C		21	A		
Pulsed Drain Current ^a			I _{DM}	120			
Linear Derating Factor			0.32	W/°C			
Single Pulse Avalanche Energy ^b		E _{AS}	400	mJ			
Maximum Power Dissipation	T _C = 25 °C		PD	48	W		
Peak Diode Recovery dV/dtc		dV/dt	4.5	V/ns			
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	- °C			
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d				
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in		
			-	1.1	N · m		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 518 μ H, R_G = 25 Ω , I_{AS} = 30 A (see fig. 12c).

c. $I_{SD} \le 51$ A, dI/dt ≤ 250 A/µs, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.

d. 1.6 mm from case.



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THERMAL RESISTANCE RA	TINGS								
PARAMETER	SYMBOL	TYP. MAX.			UNIT				
Maximum Junction-to-Ambient	R _{thJA}	- 65				°C ///			
Maximum Junction-to-Case (Drain)	R _{thJC}	-		3.1		°C/W			
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,		vise noted			1	1	1		
PARAMETER	SYMBOL	TES		ONS	MIN.	TYP.	MAX.	UNIT	
Static		1			T	T	T		
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 2	50 μA	60	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	I _D = 1 mA	-	0.070	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 2	250 μΑ	1.0	-	2.0	V	
Gate-Source Leakage	I _{GSS}	,	$V_{GS} = \pm 10^{\circ}$	V	-	-	± 100	nA	
Zero Gate Voltage Drain Current	1	$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-	-	25	μA	
	I _{DSS}	$V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 150 ^{\circ}\text{C}$			-	-	250	μΑ	
Drain Source On State Desistance	D	$V_{GS} = 5.0 V$	I _D	= 18 A ^b	-	-	0.028		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4.0 V	I _D	= 15 A ^b	-	-	0.039	Ω	
Forward Transconductance	9 _{fs}	$V_{DS} = 25 \text{ V}, \text{ I}_{D} = 18 \text{ A}^{b}$		22	-	-	S		
Dynamic						•			
Input Capacitance	C _{iss}		V _{GS} = 0 V,		-	3300	-	_	
Output Capacitance	C _{oss}		$V_{DS} = 25 V$		-	1200	-		
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	200	-	pF		
Drain to Sink Capacitance	С		f = 1.0 MHz	2	-	12	-		
Total Gate Charge	Qg			-	-	66			
Gate-Source Charge	Q _{gs}	V _{GS} = 5.0 V	$I_{\rm D} = 51$	= 51 A, V _{DS} = 48 V, see fig. 6 and 13 ^b	-	-	12	nC	
Gate-Drain Charge	Q _{gd}		see fig. 6		-	-	43		
Turn-On Delay Time	t _{d(on)}				-	17	-		
Rise Time	t _r		= 30 V, I _D =		-	230	-		
Turn-Off Delay Time	t _{d(off)}	$R_{G} = 4.6 \Omega, R_{D} = 0.56 \Omega,$ see fig. 10 ^b		-	42	-	ns		
Fall Time	t _f		coo ng. ro		-	110	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH		
Internal Source Inductance	L _S			-	7.5	-			
Drain-Source Body Diode Characteristic	s	<u>.</u>			Į	<u>.</u>	Į	1	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	30	A		
Pulsed Diode Forward Current ^a	I _{SM}	p - n junction diode			-	-		120	
Body Diode Voltage	V _{SD}	$T_J = 25 \ ^{\circ}C, \ I_S = 30 \ A, \ V_{GS} = 0 \ V^b$			-	-	2.5	V	
Body Diode Reverse Recovery Time	t _{rr}	$T_{J} = 25 \text{ °C}, I_{F} = 51 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^{b}$		-	90	180	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.65	1.3	μC		
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)						_D)	

Notes

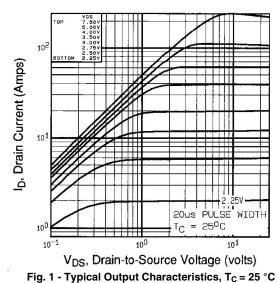
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

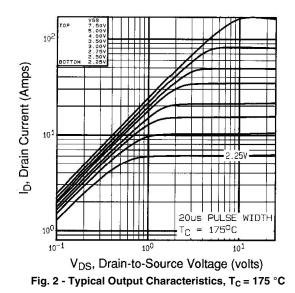
b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





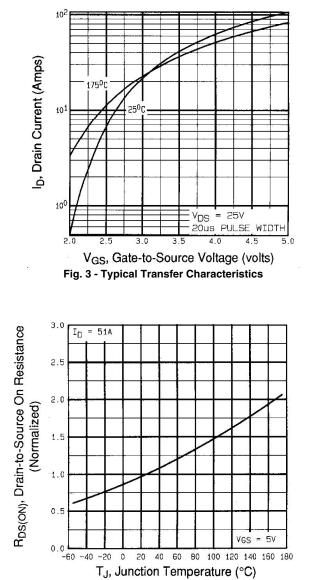


Fig. 4 - Normalized On-Resistance vs. Temperature

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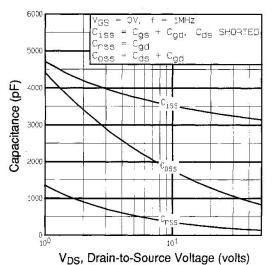


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

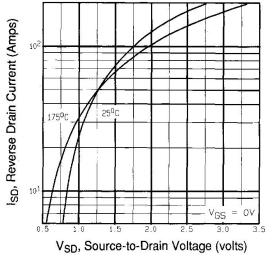


Fig. 7 - Typical Source-Drain Diode Forward Voltage

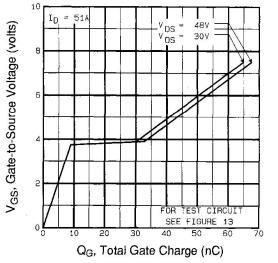
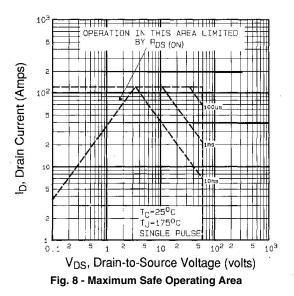


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





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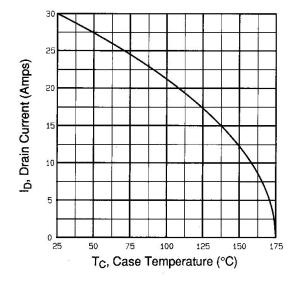


Fig. 9 - Maximum Drain Current vs. Case Temperature

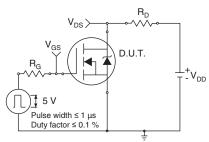


Fig. 10a - Switching Time Test Circuit

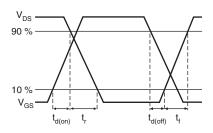
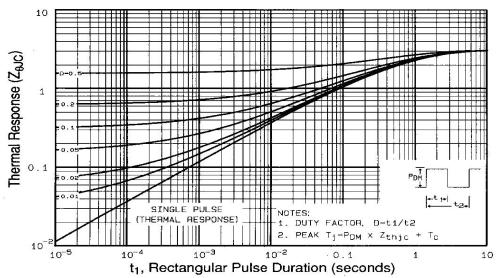


Fig. 10b - Switching Time Waveforms





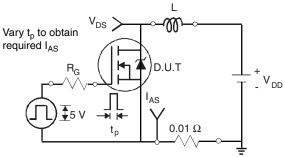


Fig. 12a - Unclamped Inductive Test Circuit

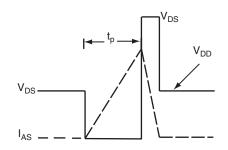


Fig. 12b - Unclamped Inductive Waveforms

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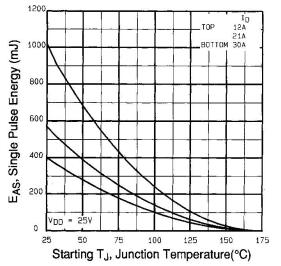


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

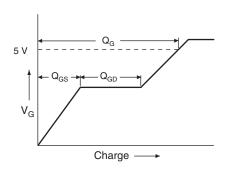
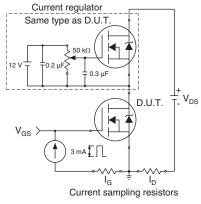


Fig. 13a - Basic Gate Charge Waveform

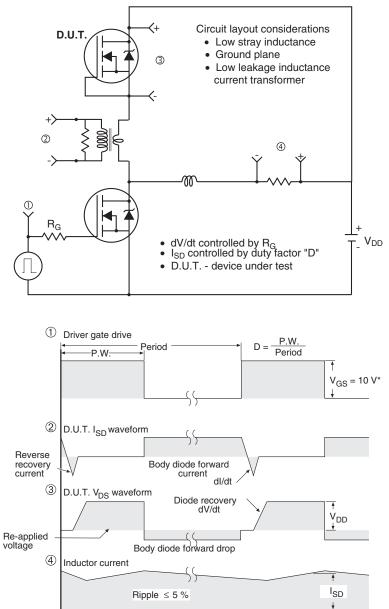






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Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level and 3 V drive devices

Fig.14 - For N-Channel

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